0039-6348-2SRD REISSUE

IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE REISSUE OF U.S. PATENT NO: 5,570,315

PATENTEE: TOMOHARU TANAKA ET AL

SERIAL NO: 09/134,897

FILED: AUGUST 17, 1998

FOR: MULTI-STATE EEPROMANNE

WRITE-VERIFY CONTROL CIRCUIT

: GROUP ART UNIT: 2824

: EXAMINER: TRAN

1014

AMENDMENT

ASSISTANT COMMISSIONER FOR PATENTS WASHINGTON, D.C. 20231

SIR:

Responsive to the Official Office Action mailed November 20, 2000, please amend the above-identified application as follows:

IN THE CLAIMS

Please amend the claims as shown in the attachment. A complete set of claims in clean form is shown below.

Please cancel without prejudice Claims 130-132, 136-138, 141-142 and 144-149.

Please amend Claims 120, 121, 123, 125, 127, 129, 133, 139, 143 and 150 as follows:

120. (Amended) A multilevel nonvolatile semiconductor memory device comprising:

a NAND-cell unit including a plurality of memory cells connected in series, each of

said memory cells including a transistor with a control gate and a charge storage portion and

having storage states of at least three threshold voltage levels:

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